

Notice of References Cited	Application/Control No. 09/647,457	Applicant(s)/Patent Under Reexamination SHINITZKY ET AL.	
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U.S. PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	Hedges et al., PNAS 91:2621-24, 1994 with alignment Accession ID I50026 database PIR_78.
	V	Byrjalsen et al., WO98/10291, 12 March 1998.
	W	Taylor et al., Experimental and Molecular Pathology, (1985 Apri) 42(2)271-7.
	X	McAleese et al., Eur. J. Biochem., 178:413-417, 1988.

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	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Jankovic B D, Journal of immunology (1985 Aug) 135 (2 Suppl) 853s-857s.
	V	
	W	
	X	

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